

# Katharina Lorenz

## List of Publications by Year in descending order

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245  
papers

4,119  
citations

126858

33  
h-index

182361

51  
g-index

248  
all docs

248  
docs citations

248  
times ranked

2914  
citing authors

#	ARTICLE	IF	CITATIONS
1	Europium-Implanted AlN Nanowires for Red Light-Emitting Diodes. ACS Applied Nano Materials, 2022, 5, 972-984.	2.4	11
2	Role of the metal supply pathway on silicon patterning by oblique ion beam sputtering. Applied Surface Science, 2022, 580, 152267.	3.1	6
3	Ion Implantation into Nonconventional GaN Structures. Physics, 2022, 4, 548-564.	0.5	1
4	Surface nanopatterning by ion beam irradiation: compositional effects. Journal of Physics Condensed Matter, 2022, 34, 333002.	0.7	8
5	Enhancing the luminescence yield of Cr <sup>3+</sup> in Ga <sub>2</sub> O <sub>3</sub> by proton irradiation. Applied Physics Letters, 2022, 120, .	1.5	8
6	Crystal mosaicity determined by a novel layer deconvolution Williamson-Hall method. CrystEngComm, 2021, 23, 2048-2062.	1.3	8
7	Molybdenum Oxide Thin Films Grown on Flexible ITO-Coated PET Substrates. Materials, 2021, 14, 821.	1.3	12
8	Eu <sup>3+</sup> optical activation engineering in Al Ga <sub>1-x</sub> N nanowires for red solid-state nano-emitters. Applied Materials Today, 2021, 22, 100893.	2.3	4
9	Unravelling the secrets of the resistance of GaN to strongly ionising radiation. Communications Physics, 2021, 4, .	2.0	26
10	Self-powered proton detectors based on GaN core-shell microwires. Applied Physics Letters, 2021, 118, .	1.5	3
11	An insider view of the Portuguese ion beam laboratory. European Physical Journal Plus, 2021, 136, 1.	1.2	15
12	Exploring swift-heavy ion irradiation of InGa <sub>n</sub> /GaN multiple quantum wells for green-emitters: the use of Raman and photoluminescence to assess the irradiation effects on the optical and structural properties. Journal of Materials Chemistry C, 2021, 9, 8809-8818.	2.7	5
13	Estimating the uncertainties of strain and damage analysis by X-ray diffraction in ion implanted MoO <sub>3</sub> . Nuclear Instruments & Methods in Physics Research B, 2020, 478, 290-296.	0.6	1
14	Ion beam induced current analysis in GaN microwires. EPJ Web of Conferences, 2020, 233, 05001.	0.1	1
15	XANES/EXAFS study of the Lu and Y incorporation in the single crystal Tb <sub>3</sub> Sc <sub>2</sub> Al <sub>3</sub> O <sub>12</sub> Faraday rotator. Journal of Applied Physics, 2020, 127, 115106.	1.1	5
16	Acceptor state anchoring in gallium nitride. Applied Physics Letters, 2020, 116, .	1.5	2
17	Tribological performance of the pair human teeth vs 3D printed zirconia: An in vitro chewing simulation study. Journal of the Mechanical Behavior of Biomedical Materials, 2020, 110, 103900.	1.5	12
18	Size control of GaN nanocrystals formed by ion implantation in thermally grown silicon dioxide. Journal of Applied Physics, 2020, 127, 034302.	1.1	4

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19	Suitability of 3D printed pieces of nanocrystalline zirconia for dental applications. <i>Dental Materials</i> , 2020, 36, 442-455.	1.6	57
20	Advanced Monte Carlo Simulations for Ion-Channeling Studies of Complex Defects in Crystals. <i>Springer Series in Materials Science</i> , 2020, , 133-160.	0.4	3
21	Micro-Opto-Electro-Mechanical Device Based on Flexible $\text{In}^{2+}\text{-Ga}^{2+}\text{O}^{3-}$ Micro-Lamellas. <i>ECS Journal of Solid State Science and Technology</i> , 2019, 8, Q3235-Q3241.	0.9	3
22	Studying electronic properties in GaN without electrical contacts using $\hat{\Gamma}^3\text{-}\hat{\Gamma}^3$ vs $\hat{e}^{\sim}\text{-}\hat{\Gamma}^3$ Perturbed Angular Correlations. <i>Scientific Reports</i> , 2019, 9, 15734.	1.6	4
23	Modelling of Optical Damage in Nanorippled ZnO Produced by Ion Irradiation. <i>Crystals</i> , 2019, 9, 453.	1.0	4
24	Measuring strain caused by ion implantation in GaN. <i>Materials Science in Semiconductor Processing</i> , 2019, 98, 95-99.	1.9	15
25	Luminescence properties of MOCVD grown $\text{Al}_{0.2}\text{Ga}_{0.8}\text{N}$ layers implanted with Tb. <i>Journal of Luminescence</i> , 2019, 210, 413-424.	1.5	1
26	Eu Activation in $\text{In}^{2+}\text{-Ga}_2\text{O}_3$ MOVPE Thin Films by Ion Implantation. <i>ECS Journal of Solid State Science and Technology</i> , 2019, 8, Q3097-Q3102.	0.9	15
27	Incorporation of Europium into GaN Nanowires by Ion Implantation. <i>Journal of Physical Chemistry C</i> , 2019, 123, 11874-11887.	1.5	12
28	Engineering strain and conductivity of $\text{MoO}_3$ by ion implantation. <i>Acta Materialia</i> , 2019, 169, 15-27.	3.8	19
29	Monte Carlo simulations of ion channeling in crystals containing dislocations and randomly displaced atoms. <i>Journal of Applied Physics</i> , 2019, 126, .	1.1	21
30	RBS/C, XRR, and XRD Studies of Damage Buildup in Er-implanted ZnO. <i>Physica Status Solidi (B): Basic Research</i> , 2019, 256, 1800364.	0.7	17
31	Strain detection in crystalline heterostructures using bidimensional blocking patterns of channelled particles. <i>Journal Physics D: Applied Physics</i> , 2018, 51, 115304.	1.3	3
32	Defect formation and optical activation of Tb implanted $\text{Al}_x\text{Ga}_{1-x}\text{N}$ films using channeled implantation at different temperatures. <i>Surface and Coatings Technology</i> , 2018, 355, 29-39.	2.2	9
33	Optical investigations of europium ion implanted in nitride-based diode structures. <i>Surface and Coatings Technology</i> , 2018, 355, 40-44.	2.2	9
34	Crystal damage analysis of implanted $\text{Al}_x\text{Ga}_{1-x}\text{N}$ ( $0 \leq x \leq 1$ ) by ion beam techniques. <i>Surface and Coatings Technology</i> , 2018, 355, 55-60.	2.2	9
35	Electrical characterization of molybdenum oxide lamellar crystals irradiated with UV light and proton beams. <i>Surface and Coatings Technology</i> , 2018, 355, 50-54.	2.2	5
36	Radiation sensors based on GaN microwires. <i>Journal Physics D: Applied Physics</i> , 2018, 51, 175105.	1.3	8

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37	Eu <sup>2+</sup> Mg defects and donor <sup>+</sup> acceptor pairs in GaN: photodissociation and the excitation transfer problem. Journal Physics D: Applied Physics, 2018, 51, 065106.	1.3	5
38	Multiple optical centers in Eu-implanted AlN nanowires for solid-state lighting applications. Applied Physics Letters, 2018, 113, 201905.	1.5	8
39	Hysteretic Photochromic Switching (HPS) in Doubly Doped GaN(Mg):Eu <sup>2+</sup> A Summary of Recent Results. Materials, 2018, 11, 1800.	1.3	5
40	In Situ Characterization and Modification of $\text{Ga}_2\text{O}_3$ Flakes Using an Ion Microprobe. Physica Status Solidi (A) Applications and Materials Science, 2018, 215, 1800190.	0.8	7
41	Eu-Doped AlGaIn/GaN Superlattice-Based Diode Structure for Red Lighting: Excitation Mechanisms and Active Sites. ACS Applied Nano Materials, 2018, 1, 3845-3858.	2.4	14
42	Spatially resolved optical activation of Eu ions by laser irradiation in implanted hexagonal MoO <sub>3</sub> microrods. Applied Physics Letters, 2018, 113, 031902.	1.5	4
43	GaN/AlGaIn multiple quantum wells grown on transparent and conductive (-201)-oriented $\text{Ga}_2\text{O}_3$ substrate for UV vertical light emitting devices. Applied Physics Letters, 2018, 113, .	1.5	44
44	Concurrent segregation and erosion effects in medium-energy iron beam patterning of silicon surfaces. Journal of Physics Condensed Matter, 2018, 30, 274001.	0.7	7
45	Raman and cathodoluminescence analysis of transition metal ion implanted Ga <sub>2</sub> O <sub>3</sub> nanowires. Journal of Luminescence, 2017, 191, 56-60.	1.5	15
46	Validity of Vegard's rule for Al <sub>1-x</sub> In <sub>x</sub> N (0.08 ≤ x ≤ 0.28) thin films grown on GaN templates. Physics D: Applied Physics, 2017, 50, 205107.	1.3	10
47	Infrared dielectric functions, phonon modes, and free-charge carrier properties of high-Al-content Al <sub>x</sub> Ga <sub>1-x</sub> N alloys determined by mid infrared spectroscopic ellipsometry and optical Hall effect. Journal of Applied Physics, 2017, 121, .	1.1	14
48	Effects of thermal annealing on the structural and electronic properties of rare earth-implanted MoO <sub>3</sub> nanoplates. CrystEngComm, 2017, 19, 2339-2348.	1.3	6
49	Hysteretic photochromic switching of Eu-Mg defects in GaN links the shallow transient and deep ground states of the Mg acceptor. Scientific Reports, 2017, 7, 41982.	1.6	11
50	Effect of buried extended defects on the radiation tolerance of ZnO. Applied Physics Letters, 2017, 110, 172103.	1.5	8
51	Doping $\text{Ga}_2\text{O}_3$ with europium: influence of the implantation and annealing temperature. Journal Physics D: Applied Physics, 2017, 50, 325101.	1.3	26
52	Implantation damage formation in a-, c- and m-plane GaN. Acta Materialia, 2017, 123, 177-187.	3.8	73
53	Luminescence of Eu <sup>3+</sup> in GaN(Mg, Eu): Transitions from the 5D <sub>1</sub> level. Applied Physics Letters, 2017, 111, .	1.5	12
54	Impact of implantation geometry and fluence on structural properties of Al <sub>x</sub> Ga <sub>1-x</sub> N implanted with thulium. Journal of Applied Physics, 2016, 120, .	1.1	10

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55	Utilization of native oxygen in Eu(RE)-doped GaN for enabling device compatibility in optoelectronic applications. Scientific Reports, 2016, 6, 18808.	1.6	29
56	Identifying the influence of the intrinsic defects in Gd-doped ZnO thin-films. Journal of Applied Physics, 2016, 119, .	1.1	52
57	Direct Measurement of Polarization-Induced Fields in GaN/AlN by Nano-Beam Electron Diffraction. Scientific Reports, 2016, 6, 28459.	1.6	25
58	Spectroscopic analysis of the NIR emission in Tm implanted Al <sub>x</sub> Ga <sub>1-x</sub> N layers. Journal of Applied Physics, 2016, 120, 081701.	1.1	9
59	Correction to "Spectroscopic Analysis of Eu <sup>3+</sup> Implanted and Annealed GaN Layers and Nanowires". Journal of Physical Chemistry C, 2016, 120, 6907-6908.	1.5	5
60	Quantitative x-ray diffraction analysis of bimodal damage distributions in Tm implanted Al <sub>0.15</sub> Ga <sub>0.85</sub> N. Journal Physics D: Applied Physics, 2016, 49, 135308.	1.3	19
61	Ion-beam induced effects in multi-layered semiconductor systems. Physica Status Solidi (B): Basic Research, 2016, 253, 2099-2109.	0.7	3
62	Self-organised silicide nanodot patterning by medium-energy ion beam sputtering of Si(100): local correlation between the morphology and metal content. Nanotechnology, 2016, 27, 444001.	1.3	12
63	Crystalfield symmetries of luminescent Eu <sup>3+</sup> centers in GaN: The importance of the 5D to 7F1 transition. Applied Physics Letters, 2016, 108, .	1.5	28
64	Analysis of the Tb <sup>3+</sup> recombination in ion implanted Al <sub>x</sub> Ga <sub>1-x</sub> N (0 ≤ x ≤ 1) layers. Journal of Luminescence, 2016, 178, 249-258.	1.5	7
65	Study of damage formation and annealing of implanted III-nitride semiconductors for optoelectronic devices. Nuclear Instruments & Methods in Physics Research B, 2016, 379, 251-254.	0.6	17
66	Mechanisms of Implantation Damage Formation in Al <sub>x</sub> Ga <sub>1-x</sub> N Compounds. Journal of Physical Chemistry C, 2016, 120, 7277-7283.	1.5	33
67	Quantum well intermixing and radiation effects in InGaN/GaN multi quantum wells. , 2016, , .		1
68	Effect of AlN content on the lattice site location of terbium ions in Al <sub>x</sub> Ga <sub>1-x</sub> N compounds. Semiconductor Science and Technology, 2016, 31, 035026.	1.0	12
69	Quantitative Chemical Mapping of InGaN Quantum Wells from Calibrated High-Angle Annular Dark Field Micrographs. Microscopy and Microanalysis, 2015, 21, 994-1005.	0.2	3
70	Luminescence studies on green emitting InGaN/GaN MQWs implanted with nitrogen. Scientific Reports, 2015, 5, 9703.	1.6	19
71	Photoluminescence studies of a perceived white light emission from a monolithic InGaN/GaN quantum well structure. Scientific Reports, 2015, 5, 13739.	1.6	19
72	Indirect excitation of Eu <sup>3+</sup> in GaN codoped with Mg and Eu. Journal of Physics: Conference Series, 2015, 619, 012025.	0.3	2

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73	Analysis of the stability of InGaN/GaN multiquantum wells against ion beam intermixing. Nanotechnology, 2015, 26, 425703.	1.3	6
74	Ion damage overrides structural disorder in silicon surface nanopatterning by low-energy ion beam sputtering. Europhysics Letters, 2015, 109, 48003.	0.7	13
75	Rare earth ion implantation and optical activation in nitride semiconductors for multicolor emission. Semiconductor Science and Technology, 2015, 30, 044004.	1.0	9
76	Spectroscopic Analysis of Eu <sup>3+</sup> Implanted and Annealed GaN Layers and Nanowires. Journal of Physical Chemistry C, 2015, 119, 17954-17964.	1.5	13
77	Composition, structure and morphology of Al <sub>1-x</sub> In <sub>x</sub> N thin films grown on Al <sub>1-y</sub> Ga <sub>y</sub> N templates with different GaN contents. Journal Physics D: Applied Physics, 2015, 48, 015103.	1.3	7
78	High In-content InGaN layers synthesized by plasma-assisted molecular-beam epitaxy: Growth conditions, strain relaxation, and In incorporation kinetics. Journal of Applied Physics, 2014, 116, .	1.1	36
79	Lattice location of Hf and its interaction with other impurities in LiNbO <sub>3</sub> : a review. Optical Engineering, 2014, 53, 060901.	0.5	4
80	Intense luminescence emission from rare-earth-doped MoO <sub>3</sub> nanoplates and lamellar crystals for optoelectronic applications. Journal Physics D: Applied Physics, 2014, 47, 355105.	1.3	28
81	GaN:Pr <sup>3+</sup> nanostructures for red solid state light emission. RSC Advances, 2014, 4, 62869-62877.	1.7	5
82	High optical and structural quality of GaN epilayers grown on (2̂01) ̂-Ga <sub>2</sub> O <sub>3</sub> . Applied Physics Letters, 2014, 105, .	1.5	60
83	Doping of Ga <sub>2</sub> O <sub>3</sub> bulk crystals and NWs by ion implantation. Proceedings of SPIE, 2014, , .	0.8	12
84	ZnO micro/nanocrystals grown by laser assisted flow deposition. , 2014, , .		1
85	Lattice location of Hf and its interaction with other impurities in LiNbO <sub>3</sub> : an integrated review. Proceedings of SPIE, 2014, , .	0.8	1
86	Study of the relationship between crystal structure and luminescence in rare-earth-implanted Ga <sub>2</sub> O <sub>3</sub> nanowires during annealing treatments. Journal of Materials Science, 2014, 49, 1279-1285.	1.7	29
87	Structural and optical properties of Ga auto-incorporated InAlN epilayers. Journal of Crystal Growth, 2014, 408, 97-101.	0.7	19
88	Europium-doped GaN(Mg): beyond the limits of the light-emitting diode. Physica Status Solidi C: Current Topics in Solid State Physics, 2014, 11, 662-665.	0.8	17
89	Determination of Ga auto-incorporation in nominal InAlN epilayers grown by MOCVD. Journal of Materials Chemistry C, 2014, 2, 5787.	2.7	21
90	Functional Nanowires: Synthesis, Characterization and Applications. Physica Status Solidi C: Current Topics in Solid State Physics, 2014, 11, 313-314.	0.8	0

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91	Sequential multiple-step europium ion implantation and annealing of GaN. <i>Physica Status Solidi C: Current Topics in Solid State Physics</i> , 2014, 11, 253-257.	0.8	9
92	Composition and luminescence studies of InGaN epilayers grown at different hydrogen flow rates. <i>Semiconductor Science and Technology</i> , 2013, 28, 065011.	1.0	13
93	Selective ion-induced intermixing and damage in low-dimensional GaN/AlN quantum structures. <i>Nanotechnology</i> , 2013, 24, 505717.	1.3	14
94	Structural and luminescence properties of Eu and Er implanted Bi <sub>2</sub> O <sub>3</sub> nanowires for optoelectronic applications. <i>Journal of Materials Chemistry C</i> , 2013, 1, 7920.	2.7	38
95	Characterisation of III-nitride materials by synchrotron X-ray microdiffraction reciprocal space mapping. <i>Physica Status Solidi C: Current Topics in Solid State Physics</i> , 2013, 10, 481-485.	0.8	5
96	The influence of photon excitation and proton irradiation on the luminescence properties of yttria stabilized zirconia doped with praseodymium ions. <i>Nuclear Instruments &amp; Methods in Physics Research B</i> , 2013, 306, 207-211.	0.6	2
97	Enhanced red emission from praseodymium-doped GaN nanowires by defect engineering. <i>Acta Materialia</i> , 2013, 61, 3278-3284.	3.8	22
98	Lattice site location and luminescence studies of Al <sub>x</sub> Ga <sub>1-x</sub> N alloys doped with thulium ions. <i>Nuclear Instruments &amp; Methods in Physics Research B</i> , 2013, 307, 495-498.	0.6	6
99	A comparative study of photo-, cathodo- and ionoluminescence of GaN nanowires implanted with rare earth ions. <i>Nuclear Instruments &amp; Methods in Physics Research B</i> , 2013, 306, 201-206.	0.6	8
100	Nanostructures and thin films of transparent conductive oxides studied by perturbed angular correlations. <i>Physica Status Solidi (B): Basic Research</i> , 2013, 250, 801-808.	0.7	4
101	Microprobe analysis, iono- and photo-luminescence of Mn <sup>2+</sup> activated ZnGa <sub>2</sub> O <sub>4</sub> fibres. <i>Nuclear Instruments &amp; Methods in Physics Research B</i> , 2013, 306, 195-200.	0.6	12
102	Towards the understanding of the intentionally induced yellow luminescence in GaN nanowires. <i>Physica Status Solidi C: Current Topics in Solid State Physics</i> , 2013, 10, 667-672.	0.8	8
103	Comparison of low- and room-temperature damage formation in Ar ion implanted GaN and ZnO. <i>Nuclear Instruments &amp; Methods in Physics Research B</i> , 2013, 307, 394-398.	0.6	34
104	Temperature-dependent hysteresis of the emission spectrum of Eu-implanted, Mg-doped HVPE GaN. <i>AIP Conference Proceedings</i> , 2013, , .	0.3	5
105	Mechanisms of Damage Formation during Rare Earth Ion Implantation in Nitride Semiconductors. <i>Japanese Journal of Applied Physics</i> , 2013, 52, 11NH02.	0.8	14
106	On the origin of strain relaxation in epitaxial CdZnO layers. , 2013, , .		0
107	Disorder induced violet/blue luminescence in rf-deposited ZnO films. <i>Physica Status Solidi C: Current Topics in Solid State Physics</i> , 2013, 10, 662-666.	0.8	13
108	Characterization of InGaN and InAlN Epilayers by Microdiffraction X-Ray Reciprocal Space Mapping. <i>Materials Research Society Symposia Proceedings</i> , 2012, 1396, .	0.1	0

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109	Mechanisms of damage formation in Eu-implanted AlN. Journal of Applied Physics, 2012, 112, .	1.1	27
110	Ion beams as a tool for the characterization of near-pseudomorphic CdZnO epilayers. , 2012, , .		1
111	Enhanced dynamic annealing and optical activation of Eu implanted a-plane GaN. Europhysics Letters, 2012, 97, 68004.	0.7	15
112	Single phase a-plane MgZnO epilayers for UV optoelectronics: substitutional behaviour of Mg at large contents. CrystEngComm, 2012, 14, 1637-1640.	1.3	29
113	Doped gallium oxide nanowires for photonics. Proceedings of SPIE, 2012, , .	0.8	10
114	Damage formation and recovery in Fe implanted 6H-SiC. Nuclear Instruments & Methods in Physics Research B, 2012, 286, 89-92.	0.6	4
115	Cd ion implantation in AlN. Nuclear Instruments & Methods in Physics Research B, 2012, 289, 43-46.	0.6	6
116	High pressure annealing of Europium implanted GaN. Proceedings of SPIE, 2012, , .	0.8	23
117	Implantation Damage Formation in GaN and ZnO. , 2012, , .		2
118	Optical doping of Al <sub>x</sub> Ga <sub>1-x</sub> N compounds by ion implantation of Tm ions. AIP Conference Proceedings, 2012, , .	0.3	5
119	Unintentional incorporation of H and related structural and free-electron properties of c- and a-plane InN. Physica Status Solidi (A) Applications and Materials Science, 2012, 209, 91-94.	0.8	4
120	Influence of neutron irradiation and annealing on the optical properties of GaN. Physica Status Solidi C: Current Topics in Solid State Physics, 2012, 9, 1016-1020.	0.8	4
121	Ion implantation of Cd and Ag into AlN and GaN. Physica Status Solidi C: Current Topics in Solid State Physics, 2012, 9, 1060-1064.	0.8	9
122	Cd doping of AlN via ion implantation studied with perturbed angular correlation. Physica Status Solidi C: Current Topics in Solid State Physics, 2012, 9, 1032-1035.	0.8	4
123	It's not easy being green: Strategies for all-colour solid state lighting. Physica Status Solidi - Rapid Research Letters, 2012, 6, 49-52.	1.2	56
124	Band gap engineering approaches to increase InGaN/GaN LED efficiency. Optical and Quantum Electronics, 2012, 44, 83-88.	1.5	17
125	Rare earth co-doping nitride layers for visible light. Materials Chemistry and Physics, 2012, 134, 716-720.	2.0	16
126	High precision determination of the InN content of Al <sub>x</sub> In <sub>1-x</sub> N thin films by Rutherford backscattering spectrometry. Nuclear Instruments & Methods in Physics Research B, 2012, 273, 105-108.	0.6	8



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127	AlN content influence on the properties of Al <sub>x</sub> Ga <sub>1-x</sub> N doped with Pr ions. Nuclear Instruments & Methods in Physics Research B, 2012, 273, 149-152.	0.6	4
128	Band gap engineering approaches to increase InGaN/GaN LED efficiency. , 2011, , .		0
129	A mechanism for damage formation in GaN during rare earth ion implantation at medium range energy and room temperature. Journal of Applied Physics, 2011, 109, .	1.1	47
130	Cathodoluminescence of rare earth implanted Ga <sub>2</sub> O <sub>3</sub> and GeO <sub>2</sub> nanostructures. Nanotechnology, 2011, 22, 285706.	1.3	39
131	Radiation damage formation and annealing in GaN and ZnO. Proceedings of SPIE, 2011, , .	0.8	54
132	Effect of Eu-implantation and annealing on the GaN quantum dots excitonic recombination. Nanoscale Research Letters, 2011, 6, 378.	3.1	6
133	Free electron properties and hydrogen in InN grown by MOVPE. Physica Status Solidi (A) Applications and Materials Science, 2011, 208, 1179-1182.	0.8	9
134	The photoluminescence/excitation (PL/E) spectroscopy of Eu-implanted GaN. Optical Materials, 2011, 33, 1063-1065.	1.7	27
135	Rapid thermal annealing of rare earth implanted ZnO epitaxial layers. Optical Materials, 2011, 33, 1139-1142.	1.7	33
136	The role of the annealing temperature on the optical and structural properties of Eu doped GaN/AlN QD. Optical Materials, 2011, 33, 1045-1049.	1.7	3
137	Structural and optical properties of Er implanted AlN thin films: Green and infrared photoluminescence at room temperature. Optical Materials, 2011, 33, 1055-1058.	1.7	11
138	Mechanisms of damage formation in Eu-implanted GaN probed by X-ray diffraction. Europhysics Letters, 2011, 96, 46002.	0.7	39
139	The high sensitivity of InN under rare earth ion implantation at medium range energy. Journal Physics D: Applied Physics, 2011, 44, 295402.	1.3	13
140	A Double Scattering Analytical Model For Elastic Recoil Detection Analysis. , 2011, , .		1
141	Unintentional incorporation of hydrogen in wurtzite InN with different surface orientations. Journal of Applied Physics, 2011, 110, .	1.1	3
142	Zeeman splittings of the <sup>5</sup> D <sub>0</sub> → <sup>7</sup> F <sub>2</sub> transitions of Eu <sup>3+</sup> ions implanted into GaN. Materials Research Society Symposia Proceedings, 2011, 1290, 1.	0.1	6
143	Damage formation in GaN under medium energy range implantation of rare earth ions: a combined TEM, XRD and RBS/C investigation. Materials Research Society Symposia Proceedings, 2011, 1342, 35.	0.1	0
144	Ternary AlGaIn Alloys with High Al Content and Enhanced Compositional Homogeneity Grown by Plasma-Assisted Molecular Beam Epitaxy. Japanese Journal of Applied Physics, 2011, 50, 031001.	0.8	9

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145	Hydrogen In Group-III Nitrides: An Ion Beam Analysis Study. , 2011, , .		1
146	Defect studies and optical activation of Yb doped GaN. Journal of Physics: Conference Series, 2010, 249, 012053.	0.3	2
147	An In-defect complex as a possible explanation for high luminous efficacy of InGaN and AlInN based devices. Hyperfine Interactions, 2010, 197, 187-191.	0.2	8
148	Thin film depth profiling using simultaneous particle backscattering and nuclear resonance profiling. Nuclear Instruments & Methods in Physics Research B, 2010, 268, 1829-1832.	0.6	18
149	High temperature annealing of Europium implanted AlN. Nuclear Instruments & Methods in Physics Research B, 2010, 268, 2907-2910.	0.6	4
150	Al <sub>1-x</sub> In <sub>x</sub> N/GaN bilayers: Structure, morphology, and optical properties. Physica Status Solidi (B): Basic Research, 2010, 247, 1740-1746.	0.7	10
151	Influence of thermal annealing on the structural and optical properties of GaN/AlN quantum dots. Physica Status Solidi (B): Basic Research, 2010, 247, 1675-1678.	0.7	5
152	Total reflectance and Raman studies in Al <sub>y</sub> In <sub>x</sub> Ga <sub>1-x-y</sub> N epitaxial layers. Physica Status Solidi C: Current Topics in Solid State Physics, 2010, 7, 56-59.	0.8	0
153	Effect of annealing on AlN/GaN quantum dot heterostructures: advanced ion beam characterization and X-ray study of low-dimensional structures. Surface and Interface Analysis, 2010, 42, 1552-1555.	0.8	6
154	The Characterization of N Interstitials and Dangling Bond Point Defects on Ion-implanted GaN Nanowires Studied by Photoluminescence and X-ray Absorption Spectroscopy. Journal of the American Ceramic Society, 2010, 93, 3531-3534.	1.9	7
155	Functionalizing self-assembled GaN quantum dot superlattices by Eu-implantation. Journal of Applied Physics, 2010, 108, 084306.	1.1	16
156	Hydrogen in InN: A ubiquitous phenomenon in molecular beam epitaxy grown material. Applied Physics Letters, 2010, 96, .	1.5	36
157	Lattice site location of optical centers in GaN:Eu light emitting diode material grown by organometallic vapor phase epitaxy. Applied Physics Letters, 2010, 97, 111911.	1.5	29
158	Optical doping and damage formation in AlN by Eu implantation. Journal of Applied Physics, 2010, 107, 023525.	1.1	38
159	Indium kinetics during the plasma-assisted molecular beam epitaxy of semipolar (11 $\bar{2}$ ) InGaN layers. Applied Physics Letters, 2010, 96, 181907.	1.5	27
160	Optical and Structural Properties of an Eu Implanted Gallium Nitride Quantum Dots/Aluminium Nitride Superlattice. Journal of Nanoscience and Nanotechnology, 2010, 10, 2473-2478.	0.9	3
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